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/ Ruth Montalvo Date: 05/05/06

Customer No. 026418

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Attorney's Docket No.: GK-OEH-237/500814.20139

U.S. Application No.:

International Application No.: PCT/DE2004/002464

International Filing Date: NOVEMBER 04, 2004

04 NOVEMBER 2004

Priority Date Claimed: NOVEMBER 07, 2003

07 NOVEMBER 2003

Title of Invention: INVERTIBLE LIGHT-OPTICAL MICROSCOPE

Applicant(s) for (DO/EO/US): Thomas Bocher, Hans Tandler, Hubert Wahl, Hans Brinkmann, Reiner Mitzkus, Franz Muchel, Harald Schadwinkel and Peter Gretscher

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INFORMATION DISCLOSURE STATEMENT

S I R:

Applicant herewith submits together with the simultaneously filed National Phase application of PCT/DE2004/002464 a copy of the International Search Report (PCT/ISA/210) dated March 14, 2005, citing the following references:

	Document Number	Date	Name and/or Country	English Translation and/or Equivalent
AA	373,634	11/22/1887	Bausch	
AB	4,210,384	07/01/1980	Meyer, et al.	
AC	4,573,772	03/04/1986	Endo, et al.	
AD	2003/0063378	04/03/2003	Koyama	
AE	2004/0001253	01/01/2004	Abe, et al.	
AL	1 807 713	06/26/1969	German	Abstract only
AM	30 37 556	05/27/1982	German	US 4,337,991
AN	32 49 807	07/09/1987	German	Abstract only
AO	2001-272606	05/10/2001	Japan	Abstract only

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Accompanying this Information Disclosure Statement and form PTO-1449 are copies of the documents w/US equivalents and/or English Abstracts. Documents AA-AB and AM are mentioned on pages 1 and 2 of the substitute specification.

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The USPTO waived the requirement under 37 C.F.R. §1.98(a)(2)(i) for submitting copies of US patents and US patent application publications in all U.S. applications filed after June 30, 2003. First pages of US documents only.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

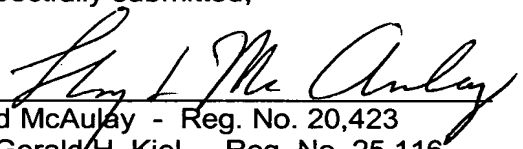
Respectfully submitted,

May 5, 2006
LMC/GHK:ram

Tel. (212) 521-5400

Enclosures:

Search Report (PCT/ISA/210);
PTO-1449
5 first page of US Patents/Publications
5 Foreign documents
w/1 First page of US equivalents and/or English Abstracts


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LIST OF PRIOR ART CITED BY APPLICANT
(Filed on May 5, 2006)

Docket No. **GK-OEH-237/500814.20139**Applicant(s): **Thomas Bocher, Hans Tandler, Hubert Wahl, Hans Brinkmann, Reiner Mitzkus, Franz Muchel, Harald Schadwinkel and Peter Gretscher**

Application No. (Int'l Appln No. PCT/DE2004/002464 04NOV04) Group:

Filed: Examiner:

U.S. PATENT DOCUMENTS

Exam. Init		Document Number	Date	Name	Class	Sub-Class	Filing Date Appropriate
	AA	373,634	11/22/1887	Bausch			
	AB	4,210,384	07/01/1980	Meyer, et al.			
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	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	CLASS	Sub-Class	Translation YES	NO
	AL	1 807 713	06/26/1969	German			Abstract only	
	AM	30 37 556	05/27/1982	German			US 4,337,991	
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	AO	2001-272606	05/10/2001	Japan			Abstract only	
	AP							
	AQ							
	AR							
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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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Examiner:

Date:

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.